

FAIRCHILD SEMICONDUCTOR

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FAIRCHILD

A Schlumberger Company

BAY73/BA129 T-01-09High Voltage Low
Leakage Diodes

- BV... 125 V (MIN) @ 100 μ A (BAY73)
- BV... 200 V (MIN) @ 100 μ A (BA129)

PACKAGES

BAY73	DO-35
BA129	DO-35

ABSOLUTE MAXIMUM RATINGS (Note 1)**Temperatures**

Storage Temperature Range

-65°C to +200°C

Maximum Junction Operating Temperature

+175°C

Lead Temperature

+260°C

Power Dissipation (Note 2)

Maximum Total Power Dissipation at 25°C Ambient

500 mW

Linear Power Derating Factor (from 25°C)

3.33 mW/°C

Maximum Voltage and Currents

WIV

Working Inverse Voltage

BAY73

100 V

BA129

180 V

 I_O

Average Rectified Current

200 mA

 I_F

Continuous Forward Current

500 mA

 I_f

Peak Repetitive Forward Current

600 mA

 I_f (surge)

Peak Forward Surge Current

1.0 A

Pulse Width = 1 s

4.0 A

Pulse Width = 1 μ s**ELECTRICAL CHARACTERISTICS** (25°C Ambient Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	BAY73		BA129		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
V_F	Forward Voltage	0.85	1.00			V	$I_F = 200$ mA
		0.81	0.94			V	$I_F = 100$ mA
		0.78	0.88	0.78	1.00	V	$I_F = 50$ mA
		0.69	0.80	0.69	0.83	V	$I_F = 10$ mA
		0.67	0.75			V	$I_F = 5.0$ mA
				0.60	0.71	V	$I_F = 1.0$ mA
		0.60	0.68	0.51	0.60	V	$I_F = 0.1$ mA
I_R	Reverse Current		500			nA	$V_R = 20$ V, $T_A = 125^\circ$ C
			5.0			nA	$V_R = 100$ V
			1.0			μ A	$V_R = 100$ V, $T_A = 125^\circ$ C
					10	nA	$V_R = 180$ V
					5.0	μ A	$V_R = 180$ V, $T_A = 100^\circ$ C
BV	Breakdown Voltage	125		200		V	$I_R = 100$ μ A
C	Capacitance		8.0		6.0	pf	$V_R = 0$, $f = 1.0$ MHz
t_{rr}	Reverse Recovery Time		3.0			μ s	$I_f = 10$ mA, $V_r = 35$ V $R_L = 1.0$ to 100 K Ω $C_L = 10$ pf, JAN 256

NOTES:

1. These ratings are limiting values above which the serviceability of the diode may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulses or low duty-cycle operation.
3. For product family characteristic curves, refer to Chapter 4, D2

